

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/532,849	MIURA ET AL.	
	Examiner	Art Unit	
	Nguyen T. Ha	2831	

Search Notes



Application/Control No.

10/532,849

Examiner

Nguyen T. Ha

**Applicant(s)/Patent under
Reexamination**

MIURA ET AL.

Art Unit

2831

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)